

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination IRWIN ET AL.	
		Examiner William J Deane	Art Unit 2642	Page 1 of 1

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	B	US-6668175	12-2003	Almgren et al.	455/522
	C	US-			
	D	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
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	M	US-			

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.